

GC2M060065K

N-Channel SiC Power MOSFET

V_{DS}	= 650 V
$R_{DS(on)}$	= 60 m
$I_D@25^\circ C$	= 41 A

Features

- 2nd Generation SiC MOSFET Technology
- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Fast Intrinsic Diode with Low Reverse Recovery (Qrr)

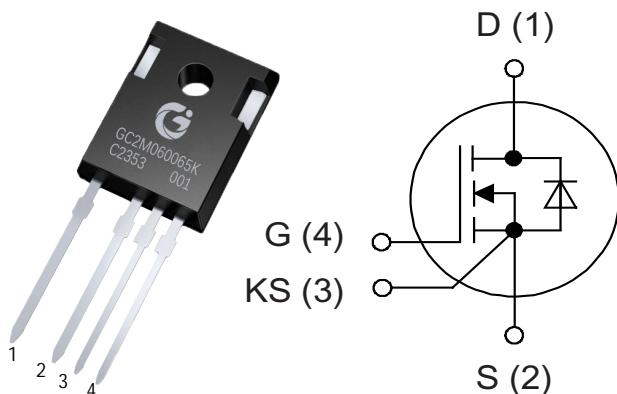
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency
- Easy to Parallel and Simple to Drive
- Enable Totem-Pole PFC Topologies

Applications

- EV Charging
- Server Power Supplies
- Solar PV Inverters
- UPS
- DC/DC Converters

Package



Part Number	Package
GC2M060065K	TO-247-4

Maximum Ratings ($T_c=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain-Source Voltage, $T_c=25^\circ C$	650	V	$V_{GS}=0V$, $I_D=100\mu A$	
V_{GSmax}	Gate-Source Voltage	-8/+22	V	Absolute maximum values	
V_{GSop}	Gate-Source Voltage	-4/+18	V	Recommended operational values	
I_D	Continuous Drain Current	41	A	$V_{GS}=18V$, $T_c=25^\circ C$	
		31		$V_{GS}=18V$, $T_c=100^\circ C$	
$I_{D(pulse)}$	Pulsed Drain Current	99	A	Pulse width t_p limited by T_{Jmax}	
P_D	Power Dissipation	166	W	$T_c=25^\circ C$, $T_J=175^\circ C$	
T_J , T_{STG}	Operating Junction and Storage Temperature	-40 to +175	°C		
T_L	Solder Temperature	260	°C		
M_d	Mounting Torque	1	Nm		

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note	
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	650	/	/	V	$V_{GS}=0\text{V}, I_D=100\mu\text{A}$		
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.6	4.0	V	$V_{DS}=V_{GS}, I_D=5\text{mA}$		
		/	1.8	/		$V_{DS}=V_{GS}, I_D=5\text{mA}, T_J=175^\circ\text{C}$		
I_{DSS}	Zero Gate Voltage Drain Current	/	1	50	μA	$V_{DS}=650\text{V}, V_{GS}=0\text{V}$		
I_{GSS}	Gate-Source Leakage Current	/	10	250	nA	$V_{DS}=0\text{V}, V_{GS}=18\text{V}$		
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	42	60	79	$\text{m}\Omega$	$V_{GS}=18\text{V}, I_D=13.2\text{A}$		
		/	75	/		$V_{GS}=18\text{V}, I_D=13.2\text{A}, T_J=175^\circ\text{C}$		
C_{iss}	Input Capacitance	/	830	/	pF	$V_{GS}=0\text{V}, V_{DS}=600\text{V}$ $f=1\text{MHz}, V_{AC}=25\text{mV}$		
C_{oss}	Output Capacitance	/	82	/				
C_{rss}	Reverse Transfer Capacitance	/	14	/				
E_{ON}	Turn-On Switching Energy	/	140	/	μJ	$V_{DS}=400\text{V}, V_{GS}=-4\text{V}/18\text{V}$ $I_D=13.2\text{A}, R_{G(\text{ext})}=2.5\Omega, L=200\mu\text{H}$		
E_{OFF}	Turn-Off Switching Energy	/	52	/				
$t_{d(on)}$	Turn-On Delay Time	/	8	/				
t_r	Rise Time	/	9	/	ns	$V_{DS}=400\text{V}, V_{GS}=-4\text{V}/18\text{V}, I_D=13.2\text{A}$ $R_{G(\text{ext})}=2.5\Omega, R_L=30\Omega$		
$t_{d(off)}$	Turn-Off Delay Time	/	21	/				
t_f	Fall Time	/	8	/				
$R_{G(\text{int})}$	Internal Gate Resistance	/	6	/	Ω	$f=1\text{MHz}, V_{AC}=25\text{mV}$ $V_{DS}=400\text{V}$ $V_{GS}=-4\text{V}/18\text{V}$ $I_D=13.2\text{A}$		
Q_{GS}	Gate to Source Charge	/	13	/	nC			
Q_{GD}	Gate to Drain Charge	/	12	/				
Q_G	Total Gate Charge	/	50	/				

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.2	/	V	$V_{GS}=-4\text{V}, I_{SD}=6.6\text{A}$	
		3.8	/		$V_{GS}=-4\text{V}, I_{SD}=6.6\text{A}, T_J=175^\circ\text{C}$	
I_S	Continuous Diode Forward Current	/	23	A	$V_{GS}=-4\text{V}, T_c=25^\circ\text{C}$	
t_{rr}	Reverse Recover Time	28	/	ns	$V_R=400\text{V}, I_{SD}=13.2\text{A}$	
Q_{rr}	Reverse Recovery Charge	47	/	nC		
I_{rrm}	Peak Reverse Recovery Current	3	/	A		

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.9	/	$^\circ\text{C}/\text{W}$		
$R_{\theta JA}$		40	/			

Typical Performance

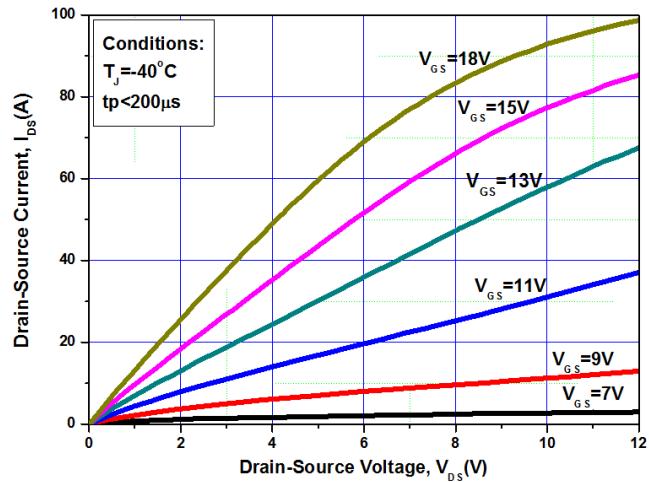


Figure 1. Output Characteristics $T_j = -40^\circ\text{C}$

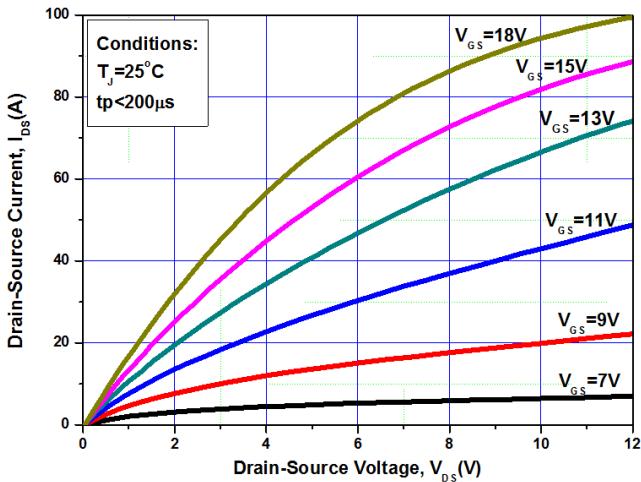


Figure 2. Output Characteristics $T_j = 25^\circ\text{C}$

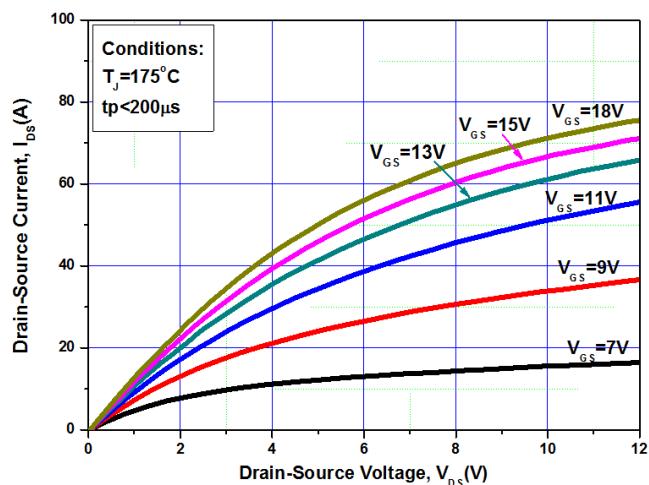


Figure 3. Output Characteristics $T_j = 175^\circ\text{C}$

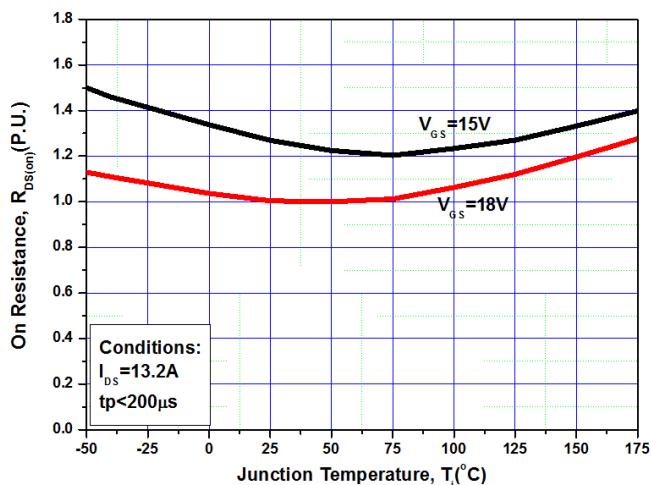


Figure 4. Normalized On-Resistance vs. Temperature

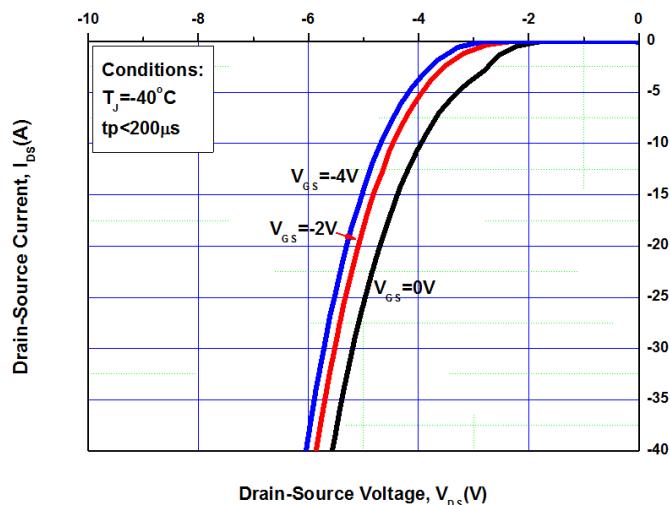


Figure 5. Body Diode Characteristic at -40°C

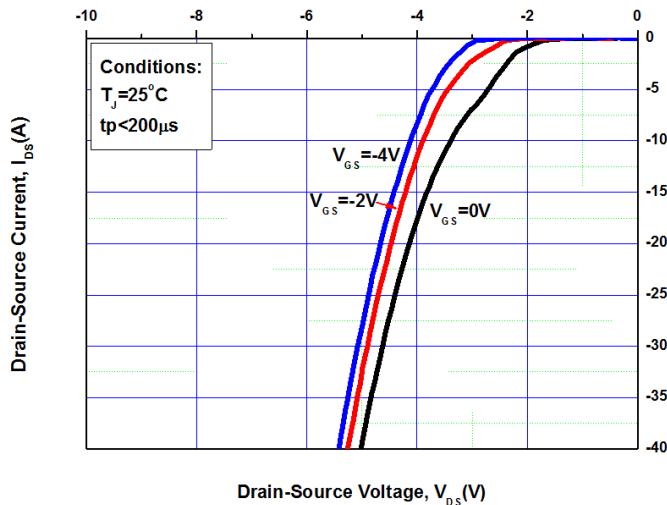


Figure 6. Body Diode Characteristic at 25°C

Typical Performance

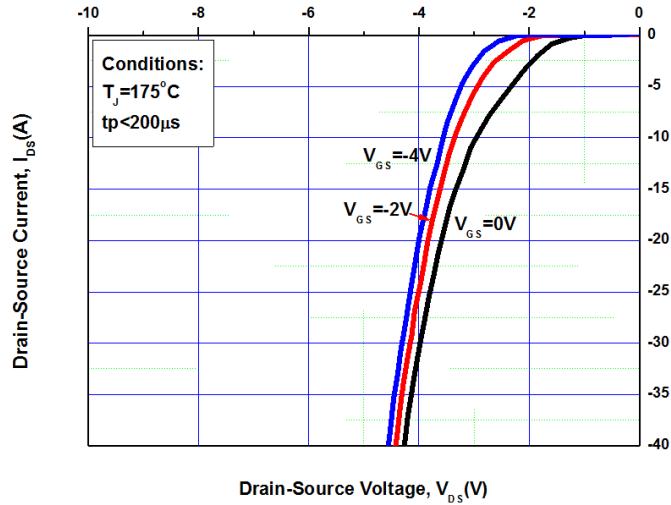


Figure 7. Body Diode Characteristic at 175°C

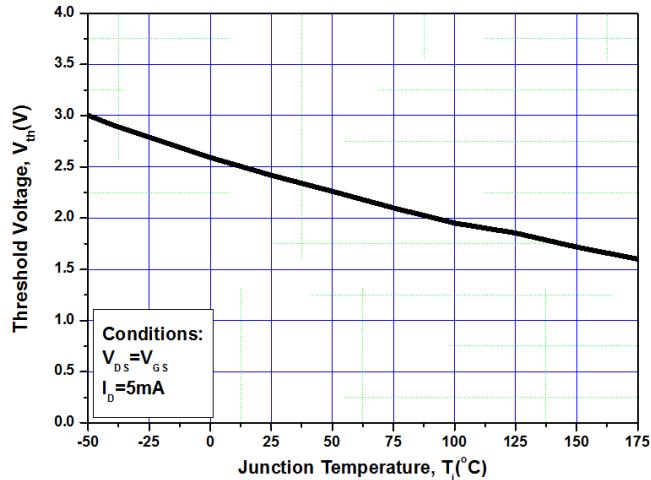


Figure 8. Threshold Voltage vs. Temperature

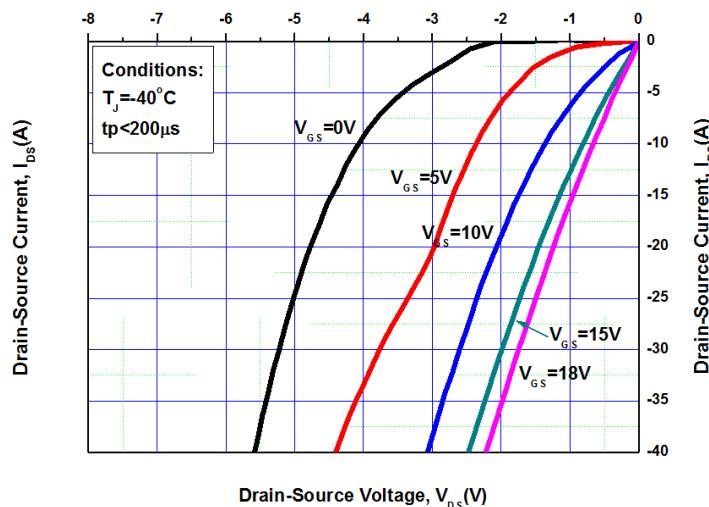


Figure 9. 3rd Quadrant Characteristic at -40°C

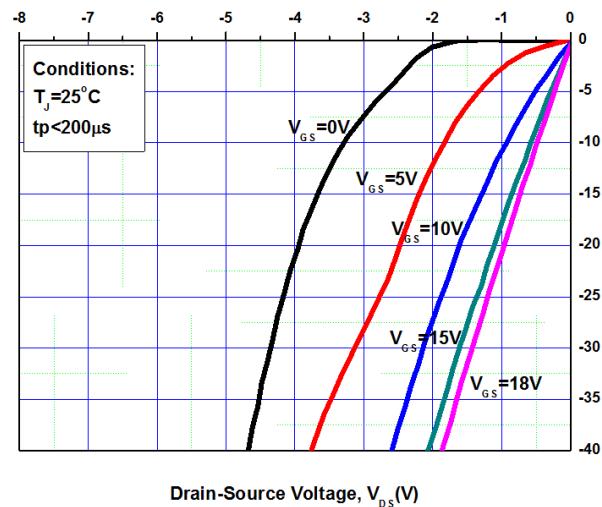


Figure 10. 3rd Quadrant Characteristic at 25°C

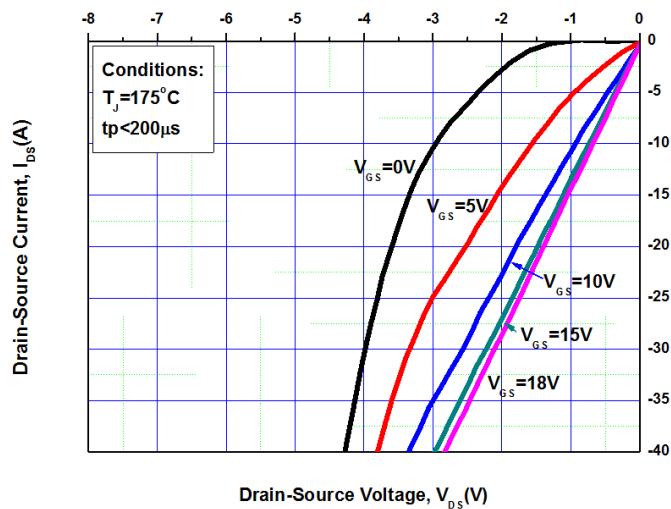


Figure 11. 3rd Quadrant Characteristic at 175°C

Typical Performance

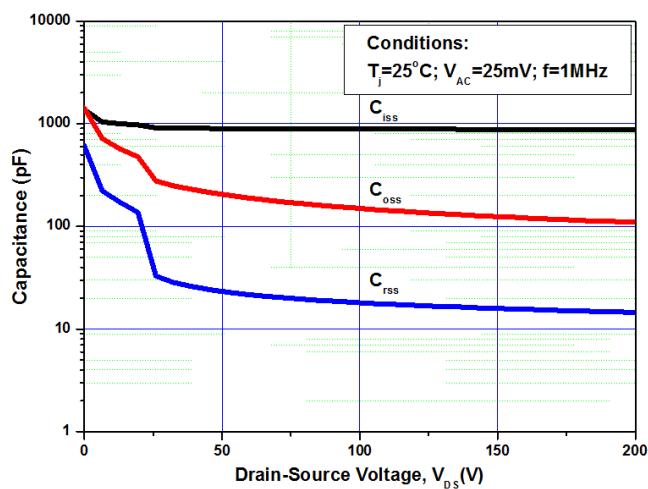


Figure 12. Capacitances vs. Drain-Source Voltage (0 - 200V)

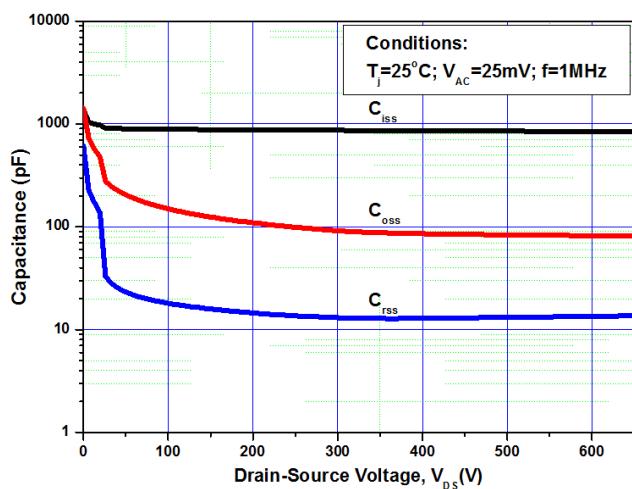
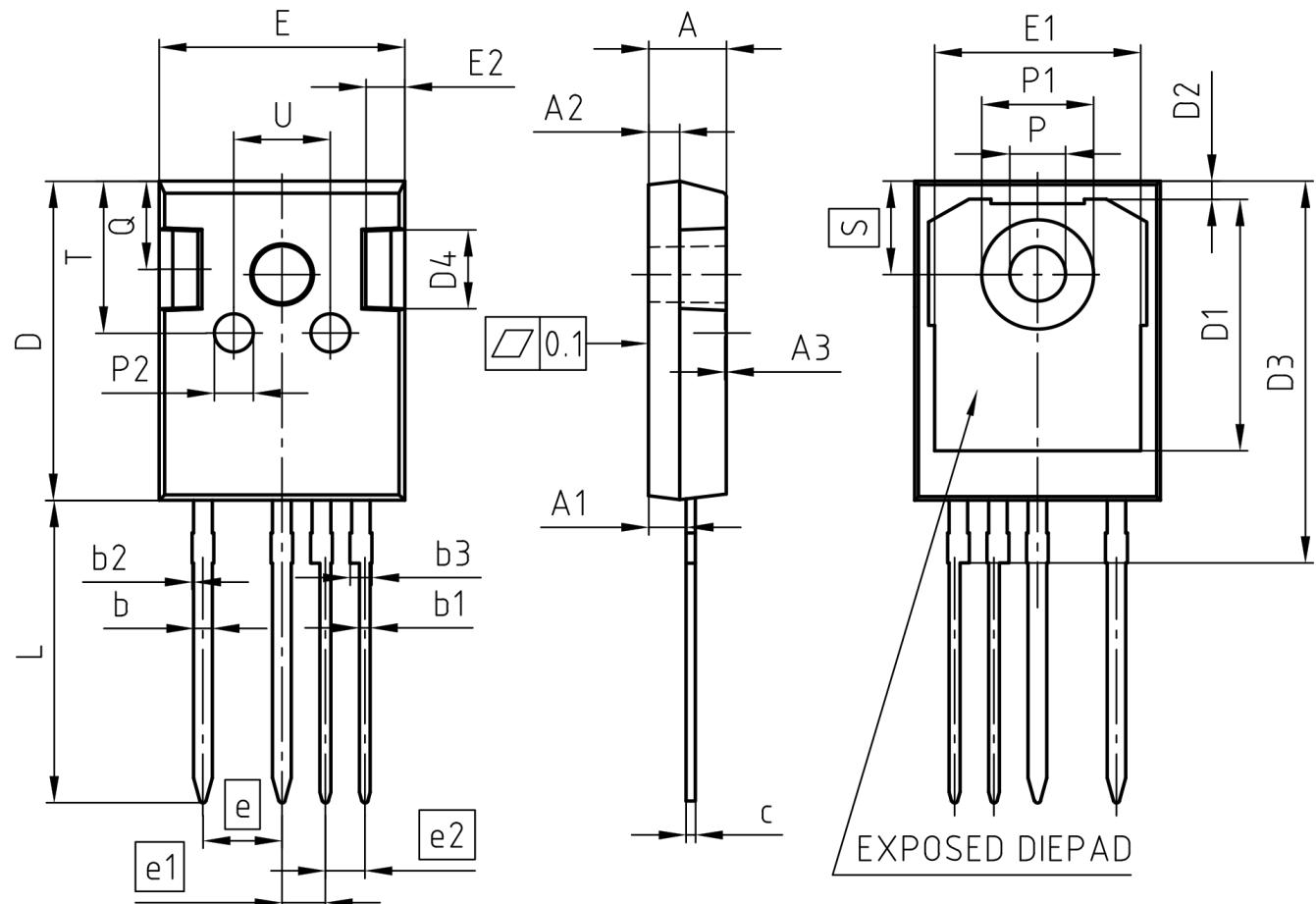


Figure 13. Capacitances vs. Drain-Source Voltage (0 - 650V)

Package Dimensions: TO-247-4



NOTES:

ALL DIMENSIONS DO NOT INCLUDE MOLD FLASH
OR PROTRUSIONS.

PACKAGE - GROUP NUMBER:		PG-TO247-4			
DIMENSIONS	MILLIMETERS		DIMENSIONS	MILLIMETERS	
	MIN.	MAX.		MIN.	MAX.
A	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.05	0.25	e	5.08	
b	1.10	1.30	e1	2.79	
b1	0.65	0.79	e2	2.54	
b2	---	0.20	N	4	
b3	1.34	1.44	L	19.80	20.10
c	0.58	0.66	øP	3.50	3.70
D	20.90	21.10	øP1	7.00	7.40
D1	16.25	16.85	øP2	2.40	2.60
D2	1.05	1.35	Q	5.60	6.00
D3	24.97	25.27	S	6.15	
D4	4.90	5.10	T	9.80	10.20
			U	6.00	6.40